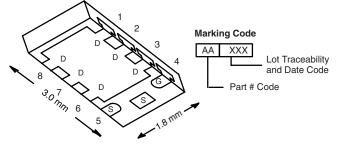


Vishay Siliconix

### N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
60	0.034 at V <sub>GS</sub> = 10 V	12	10.5 nC			
60	0.041 at V <sub>GS</sub> = 4.5 V	12	10.5110			

PowerPAK ChipFET Single



Bottom View

Ordering Information: Si5476DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

#### FEATURES

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- New Thermally Enhanced PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Package
  - Small Footprint Area
  - Low On-Resistance
  - Thin 0.8 mm Profile

#### **APPLICATIONS**

- Load Switch for Portable Applications
- DC-DC Switch for Low Power Synchronous Rectification
- Intermediate Switch Driver for DC/DC Applications



COMPLIANT



G

D

N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	<b>S</b> T <sub>A</sub> = 25 °C, unle	ss otherwise note	ed	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		12 <sup>a</sup>	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		12 <sup>a</sup>	
Continuous Drain Guneni (1) = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	7 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		5.6 <sup>b, c</sup>	A
Pulsed Drain Current		I <sub>DM</sub>	25	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	12 <sup>a</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	'S	2.6 <sup>b, c</sup>	
Avalanche Current		I <sub>AS</sub>	15	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11.2	mJ
	T <sub>C</sub> = 25 °C		31	
Movimum Dower Dissinction	T <sub>C</sub> = 70 °C	PD	20	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	۲D	3.1 <sup>b, c</sup>	vv
	T <sub>A</sub> = 70 °C		2 <sup>b, c</sup>	
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260	-U

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	34	40	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	3	4	0/11		

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 90 °C/W.



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	60			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A		55		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 6.3		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1		3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ
Zero Gate Voltage Drain Current	DSS	$V_{DS}$ = 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	25			Α
	P	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4.6 \text{ A}$		0.028	0.034	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 4.2 \text{ A}$		0.033	0.041	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 4.6 A		20		S
Dynamic <sup>b</sup>					<b></b>	1
Input Capacitance	C <sub>iss</sub>			1100		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		90		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			55		
	Qg	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 4.6 \text{ A}$		21	32	nC
Total Gate Charge				10.5	16	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 30 V, $V_{GS}$ = 4.5 V, $I_{D}$ = 4.6 A		3.5		
Gate-Drain Charge	Q <sub>gd</sub>			4.2		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		3.3		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			20	30	- ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 5.4 $\Omega$		150	225	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D} \cong 5.6$ A, $\text{V}_\text{GEN}$ = 4.5 V, $\text{R}_\text{g}$ = 1 $\Omega$		20	30	
Fall Time	t <sub>f</sub>			60	90	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 5.4 $\Omega$		15	25	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5.6$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		22	40	
Fall Time	t <sub>f</sub>			10	15	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			12	•
Pulse Diode Forward Current	I <sub>SM</sub>				25	A
Body Diode Voltage	V <sub>SD</sub>	$I_{S} = 5.5 \text{ A}, V_{GS} = 0 \text{ V}$		0.85	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			25	50	nC
Reverse Recovery Fall Time	ta	$I_F = 5.5 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		19		1
Reverse Recovery Rise Time		t <sub>b</sub>		6		ns

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



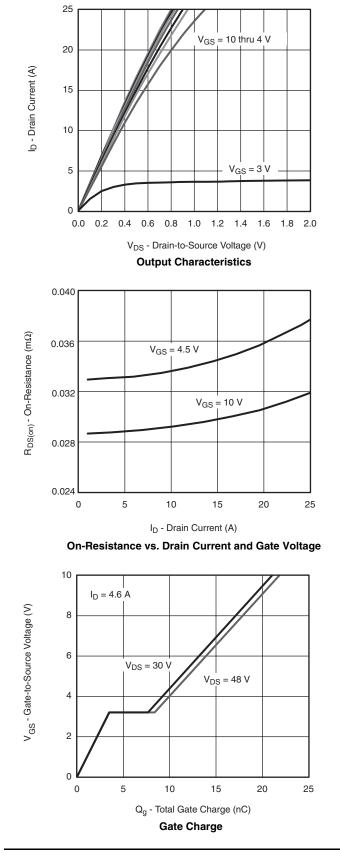
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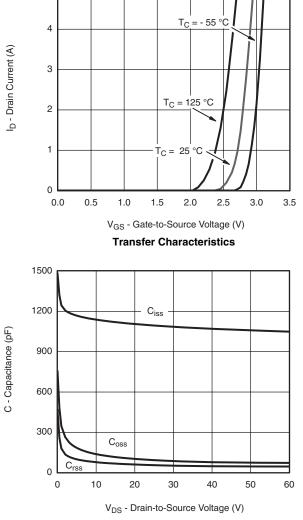


### Si5476DU

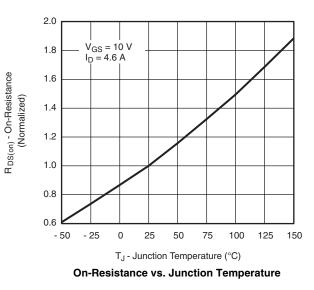
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#### **TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted





Capacitance

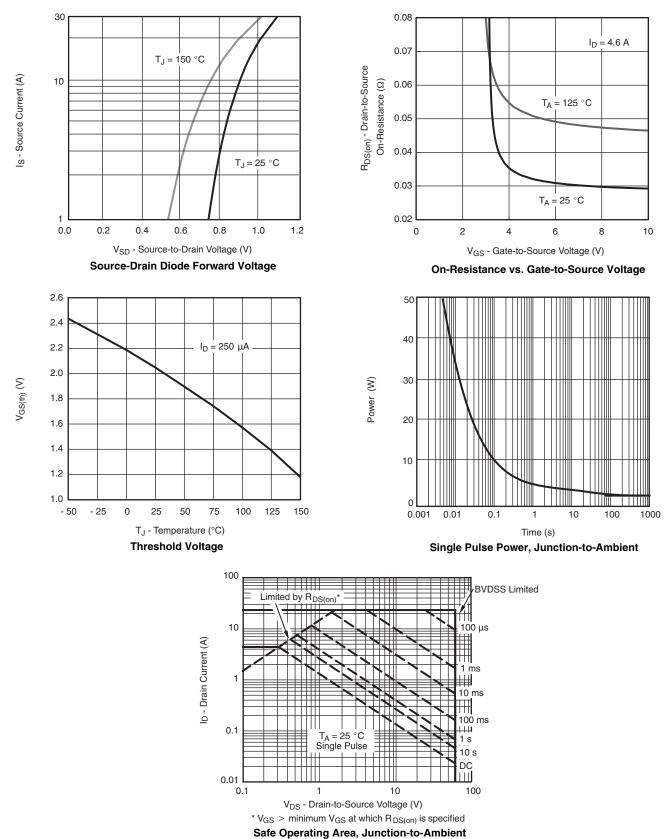


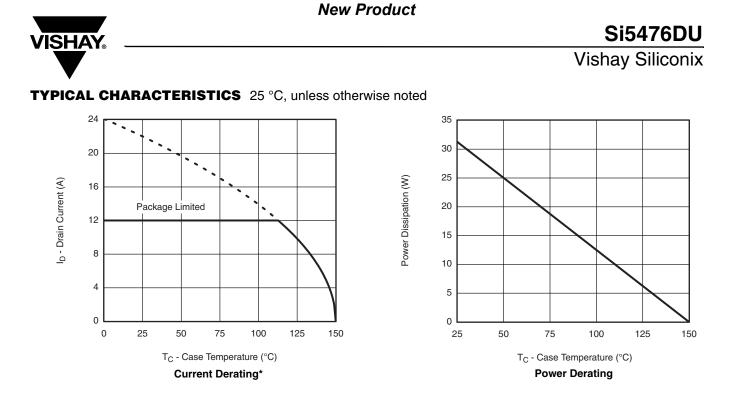
Document Number: 73663 S-81448-Rev. B, 23-Jun-08



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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



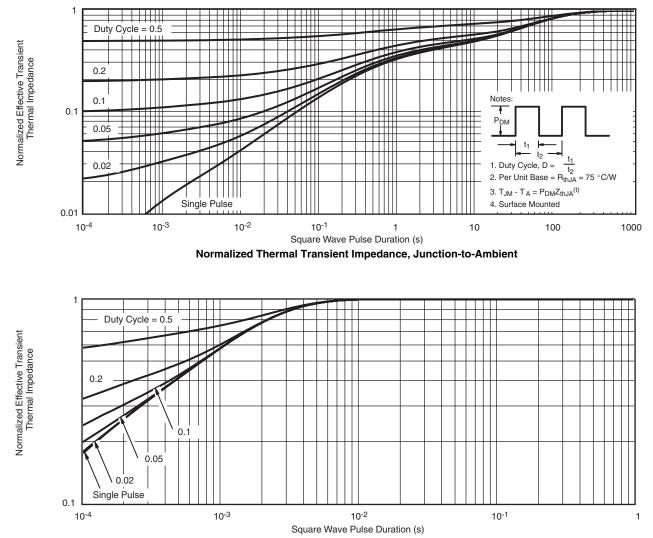


\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



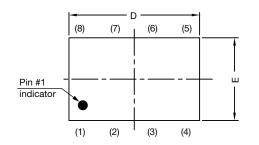
Normalized Thermal Transient Impedance, Junction-to-Case

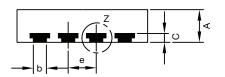
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?73663.

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# PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Case Outline

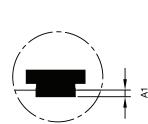




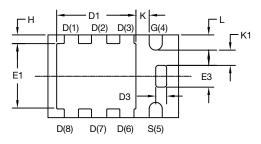


Side view of dual

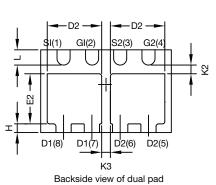
Side view of single



Detail Z



### Backside view of single pad



DIM.	MILLIMETERS			INCHES				
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
А	0.70	0.75	0.85	0.028	0.030	0.033		
A1	0	-	0.05	0	-	0.002		
b	0.25	0.30	0.35	0.010	0.012	0.014		
С	0.15	0.20	0.25	0.006	0.008	0.010		
D	2.92	3.00	3.08	0.115	0.118	0.121		
D1	1.75	1.87	2.00	0.069	0.074	0.079		
D2	1.07	1.20	1.32	0.042	0.047	0.052		
D3	0.20	0.25	0.30	0.008	0.010	0.012		
E	1.82	1.90	1.98	0.072	0.075	0.078		
E1	1.38	1.50	1.63	0.054	0.059	0.064		
E2	0.92	1.05	1.17	0.036	0.041	0.046		
E3	0.45	0.50	0.55	0.018	0.020	0.022		
е		0.65 BSC			0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010		
К	0.25	-	-	0.010	-	-		
K1	0.30	-	-	0.012	-	-		
K2	0.20	-	-	0.008	-	-		
K3	0.20	-	-	0.008	-	-		
L	0.30	0.35	0.40	0.012	0.014	0.016		
C14-0630-Rev. E DWG: 5940	, 21-Jul-14							

#### Note

• Millimeters will govern

Revision: 21-Jul-14

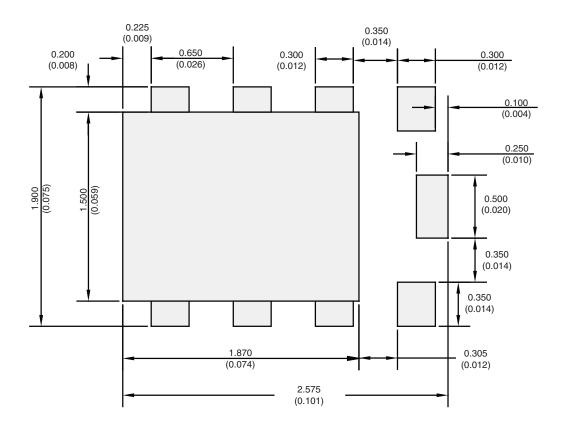
1 For technical questions, contact: <u>pmostechsupport@vishay.com</u>

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# Application Note 826 Vishay Siliconix

### RECOMMENDED MINIMUM PADS FOR PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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